DATA SHEET

MOS FIELD EFFECT TRANSISTOR

NP48N055CLE, NP48N055DLE, NP48N055ELE

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance $R_{DS(on)1} = 17 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 24 \text{ A})$ $R_{DS(on)2} = 21 \text{ m}\Omega \text{ MAX.} (V_{GS} = 5 \text{ V}, \text{ ID} = 24 \text{ A})$
- Low Ciss : Ciss = 1970 pF TYP.
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

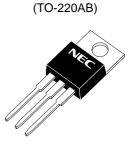
| | Drain to Source Voltage | VDSS | 55 | V |
|---|---|---|----------------|----|
| | Gate to Source Voltage | Vgss | <u>±</u> 20 | V |
| | Drain Current (DC) | D(DC) | <u>±</u> 48 | А |
| ٢ | Drain Current (Pulse) Note1 | D(pulse) | ±140 | А |
| | Total Power Dissipation (T _A = 25°C) | Pτ | 1.8 | W |
| | Total Power Dissipation (Tc = 25°C) | Ρτ | 85 | W |
| | Single Avalanche Current Note2 | AS | 46 / 27 / 10 | А |
| | Single Avalanche Energy Note2 | EAS | 2.1 / 73 / 100 | mJ |
| | Channel Temperature | Tch | 175 | °C |
| | Storage Temperature | Tstg | -55 to +175 | °C |
| | Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 % | 1 | | |
| | 2. Starting Tch = 25 °C, RG = 25 s | rgy ^{Note2} EAS 2.1 / 73 / 100 mJ T _{ch} 175 °C T _{stg} -55 to +175 °C | | |

THERMAL RESISTANCE

| Channel to Case | Rth(ch-C) | 1.76 | °C/W |
|--------------------|-----------|------|------|
| Channel to Ambient | Rth(ch-A) | 83.3 | °C/W |

ORDERING INFORMATION

| PART NUMBER | PACKAGE | | |
|-------------|----------|--|--|
| NP48N055CLE | TO-220AB | | |
| NP48N055DLE | TO-262 | | |
| NP48N055ELE | TO-263 | | |







(TO-263)

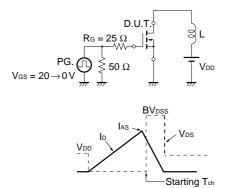


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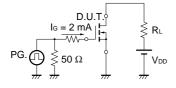
★ ELECTRICAL CHARACTERISTICS (T_A = 25 °C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|-----------------|--|------|------|------|------|
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, Id = 24 A | | 13 | 17 | mΩ |
| | RDS(on)2 | Vgs = 5 V, Id = 24 A | | 16 | 21 | mΩ |
| | RDS(on)3 | Vgs = 4.5 V, Id = 24 A | | 18 | 24 | mΩ |
| Gate to Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 24 A | 13 | 25 | | S |
| Drain Leakage Current | loss | Vds = 55 V, Vgs = 0 V | | | 10 | μA |
| Gate to Source Leakage Current | lgss | $V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ | | | ±10 | μA |
| Input Capacitance | Ciss | V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz | | 1970 | 3000 | pF |
| Output Capacitance | Coss | | | 250 | 380 | pF |
| Reverse Transfer Capacitance | Crss | | | 130 | 240 | pF |
| Turn-on Delay Time | td(on) | $I_D = 24 A, V_{GS(on)} = 10 V, V_{DD} = 28 V,$ | | 17 | 38 | ns |
| Rise Time | tr | R _G = 1 Ω | | 11 | 27 | ns |
| Turn-off Delay Time | td(off) | | | 54 | 110 | ns |
| Fall Time | tr | | | 9.3 | 23 | ns |
| Total Gate Charge 1 | Q _{G1} | $I_D = 48 \text{ A}, V_{DD} = 44 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ | | 40 | 60 | nC |
| Total Gate Charge 2 | Q _{G2} | ID = 48 A, VDD = 44 V, VGS = 5 V | | 21 | 32 | nC |
| Gate to Source Charge | QGS | | | 7 | | nC |
| Gate to Drain Charge | Qgd | | | 10 | | nC |
| Body Diode Forward Voltage | VF(S-D) | IF = 48 A, VGS = 0 V | | 1.0 | | V |
| Reverse Recovery Time | trr | IF = 48 A, VGS = 0 V, di/dt = 100 A/µs | | 40 | | ns |
| Reverse Recovery Charge | Qrr |] | | 55 | | nC |

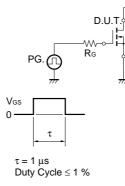
TEST CIRCUIT 1 AVALANCHE CAPABILITY

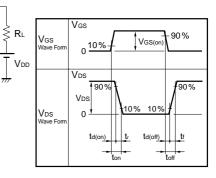


TEST CIRCUIT 3 GATE CHARGE



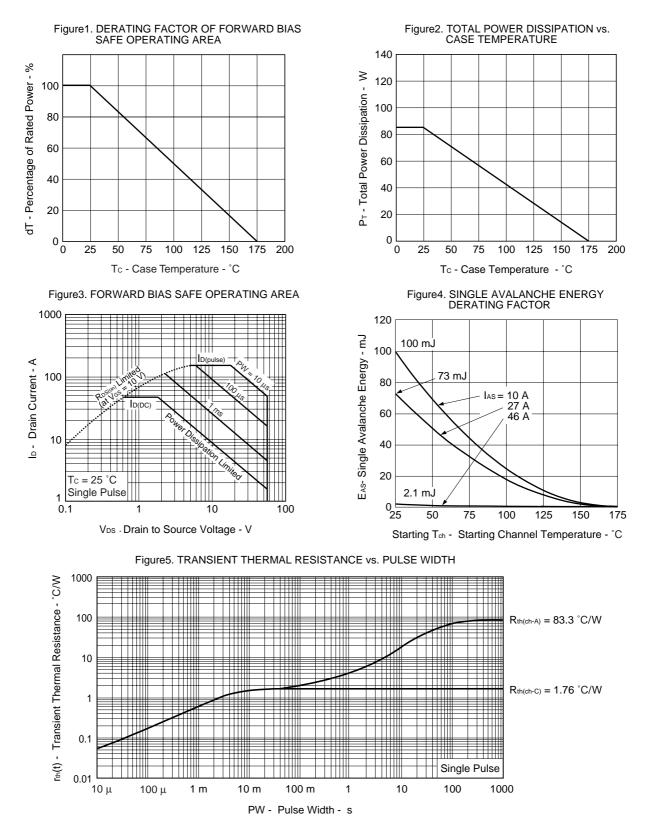
TEST CIRCUIT 2 SWITCHING TIME





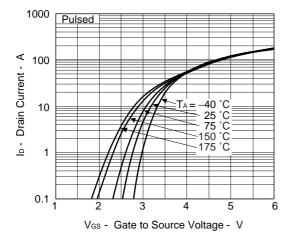
Data Sheet D14095EJ2V0DS00

* TYPICAL CHARACTERISTICS (TA = 25°C)



Data Sheet D14095EJ2V0DS00

Figure6. FORWARD TRANSFER CHARACTERISTICS



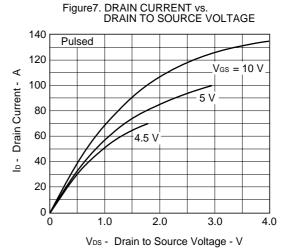


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

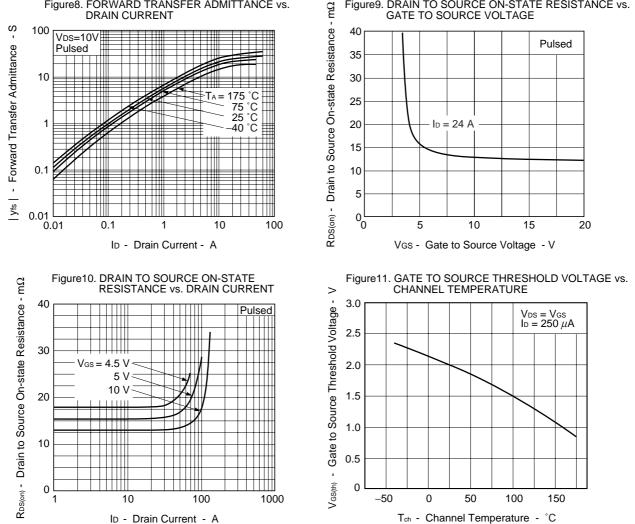


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

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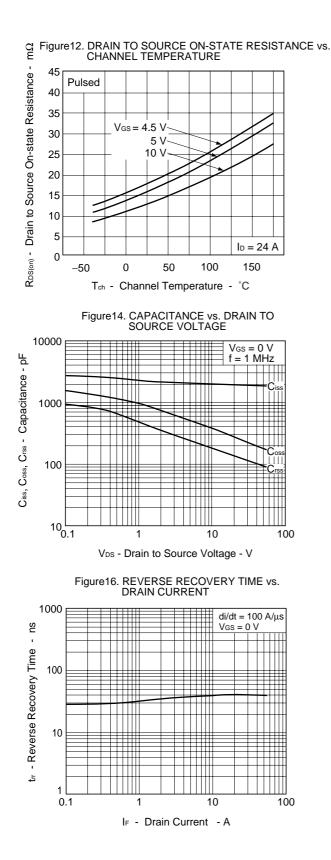
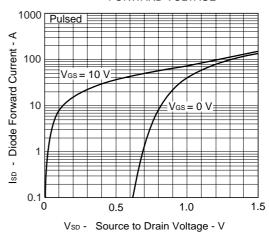
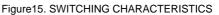
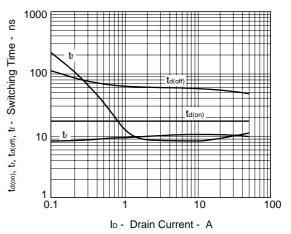
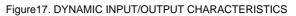


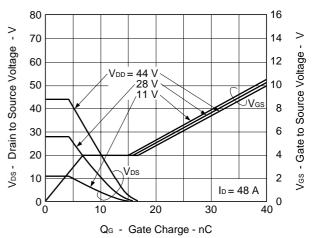
Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE





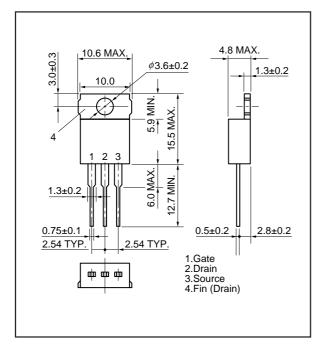




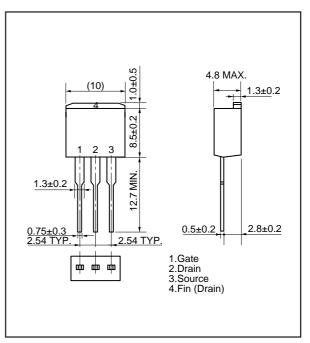


PACKAGE DRAWINGS (Unit: mm)

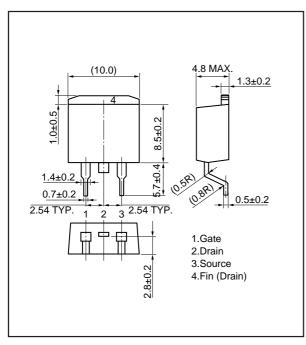
1) TO-220AB (MP-25)



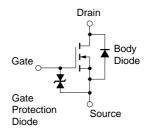
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device. [MEMO]

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